Maplesemi

LEAD FREE Pb RoHS

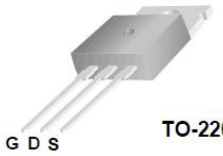
SLP10N65S/ SLF10N65S
650V N-Channel MOSFET

General Description

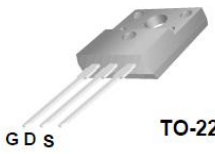
This Power MOSFET is produced using Maple semi's advanced planar stripe DMOS technology.
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

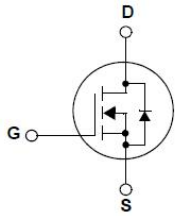
- 10A, 650V, $R_{DS(on)\ typ}$=0.8Ω@V_{GS} = 10 V
- Low gate charge (typical 28.5nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



TO-220



TO-220F



Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter	SLP10N65S	SLF10N65S	Units
V_{DSS}	Drain-Source Voltage	650		V
I_D	Drain Current - Continuous (T_C = 25℃)	10		A
	- Continuous (T_C = 100℃)	6.3		A
I_{DM}	Drain Current - Pulsed (Note 1)	40		A
V_{GSS}	Gate-Source Voltage	±30		V
EAS	Single Pulsed Avalanche Energy (Note 2)	618		mJ
I_{AR}	Avalanche Current (Note 1)	10		A
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5		V/ns
P_D	Power Dissipation (T_C = 25℃)	156	50	W
	- Derate above 25℃	1.25	0.4	W/℃
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150		℃
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300		℃

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	SLP10N65S	SLF10N65S	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.8	2.5	℃/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	℃/W

Electrical Characteristics

T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 uA	650	--	--	V
$\triangle BV_{DSS}$ / $\triangle T_J$	Breakdown Voltage Temperature Coefficient	I_D = 250 uA, Referenced to 25℃	--	1.1	--	V/℃
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 650 V, V_{GS} = 0 V	--	--	1	uA
		V_{DS} = 520 V, T_C = 125℃	--	--	10	uA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 30 V, V_{DS} = 0 V	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -30 V, V_{DS} = 0 V	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 uA	2.0	--	4.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 10 V, I_D = 5 A	--	0.8	0.95	Ω
g_{FS}	Forward Transconductance	V_{DS} = 40 V, I_D = 5 A (Note 4)	--	10	--	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz	--	1100	--	pF
C_{oss}	Output Capacitance		--	130	--	pF
C_{rss}	Reverse Transfer Capacitance		--	12.5	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 325V, I_D = 10 A, R_G = 25 Ω (Note 4, 5)	--	21	--	ns
t_r	Turn-On Rise Time		--	41	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	82	--	ns
t_f	Turn-Off Fall Time		--	42	--	ns
Q_g	Total Gate Charge	V_{DS} = 520 V, I_D = 10 A, V_{GS} = 10 V (Note 4, 5)	--	28.5	--	nC
Q_{gs}	Gate-Source Charge		--	6.2	--	nC
Q_{gd}	Gate-Drain Charge		--	13.2	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		--	--	10	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	40	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 10A	--	--	1.3	V
t_{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_S = 10A, dI_F / dt = 100 A/us (Note 4)	--	561	--	ns
Q_{rr}	Reverse Recovery Charge		--	4.3	--	uC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. I_{AS} = 6.4A,L=30mH, V_{DD} = 50V, R_G = 25Ω, Starting T_J = 25°C
3. $I_{SD} \leq$ 10A, di/dt ≤ 200A/us, $V_{DD} \leq BV_{DSS,}$ Starting T_J = 25°C
4. Pulse Test : Pulse width ≤ 300us, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

Typical Characteristics

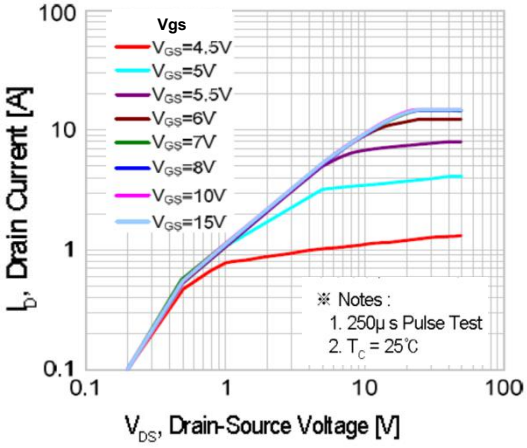


Figure 1. On-Region Characteristics

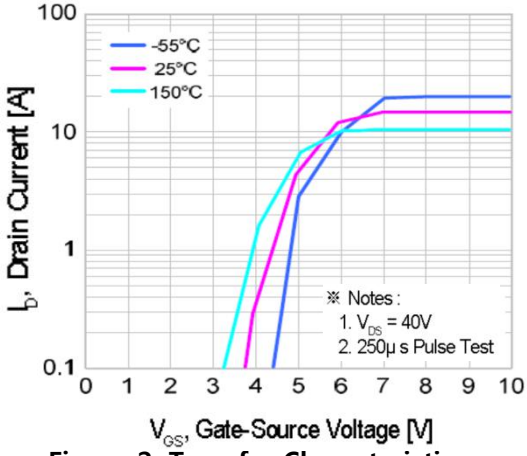


Figure 2. Transfer Characteristics

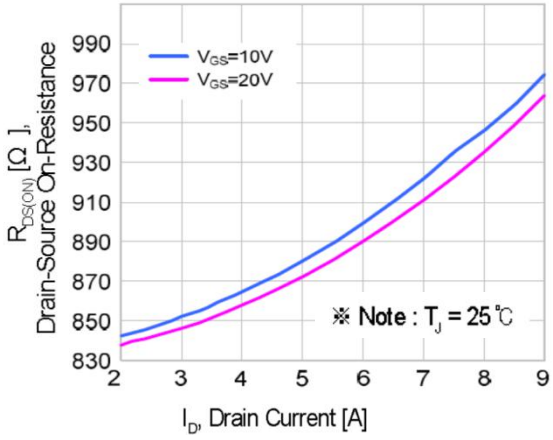


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

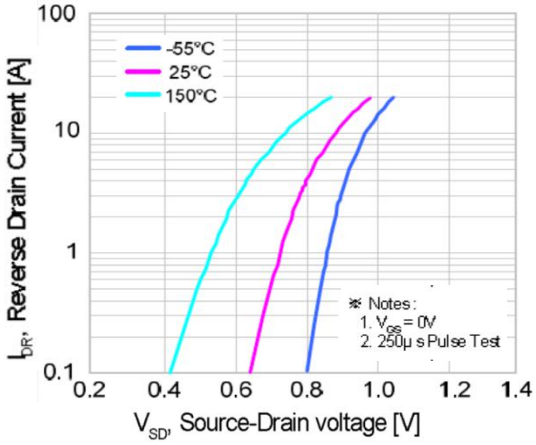


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

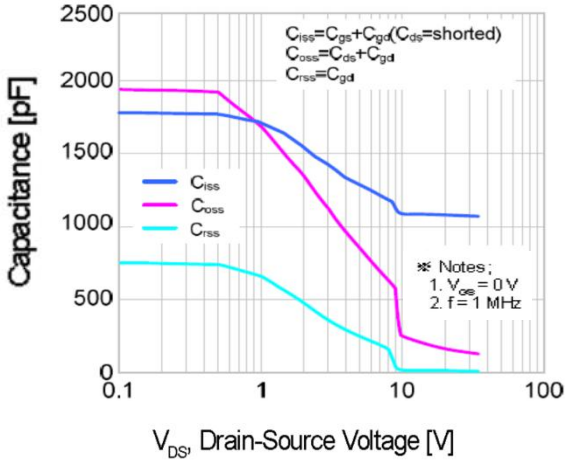


Figure 5. Capacitance Characteristics

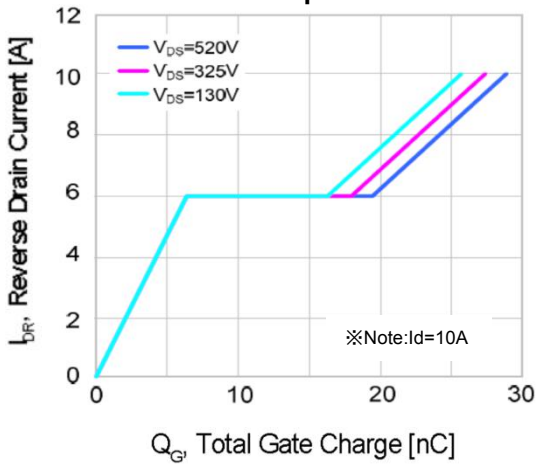


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

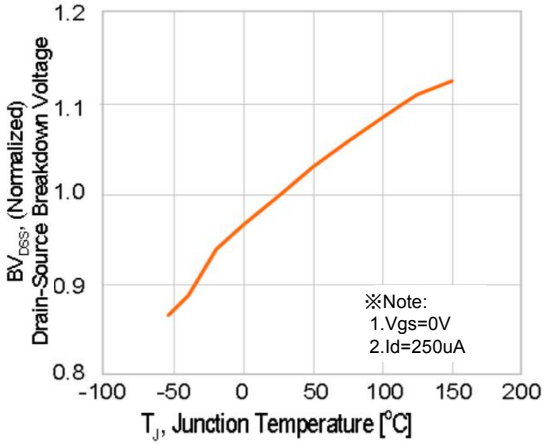


Figure 7. Breakdown Voltage Variation vs Temperature

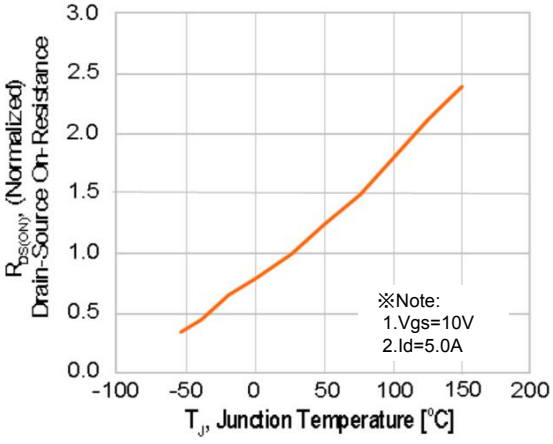


Figure 8. On-Resistance Variation vs Temperature

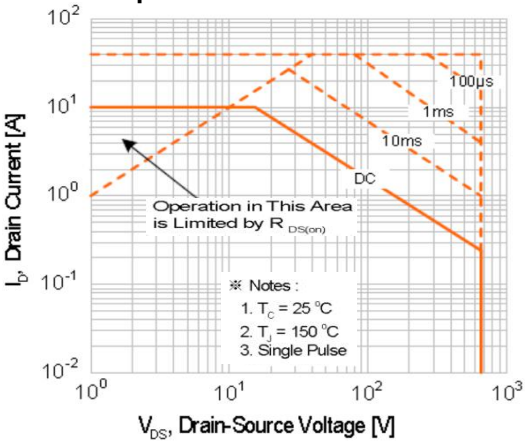


Figure 9-1. Maximum Safe Operating Area (SLP10N65S)

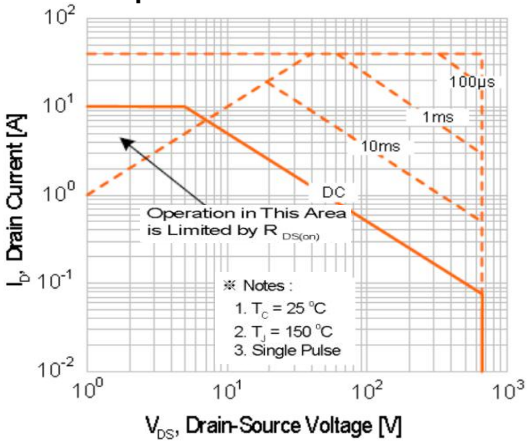


Figure 9-2. Maximum Safe Operating Area (SLF10N65S)

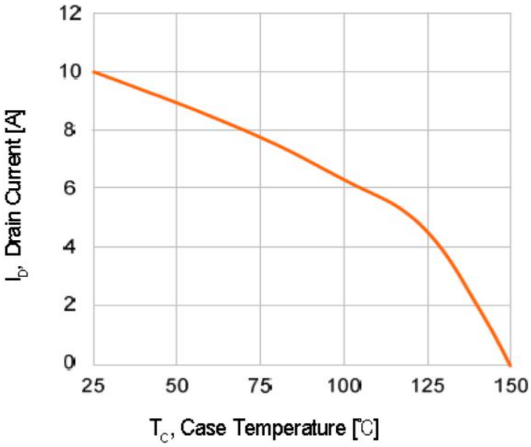
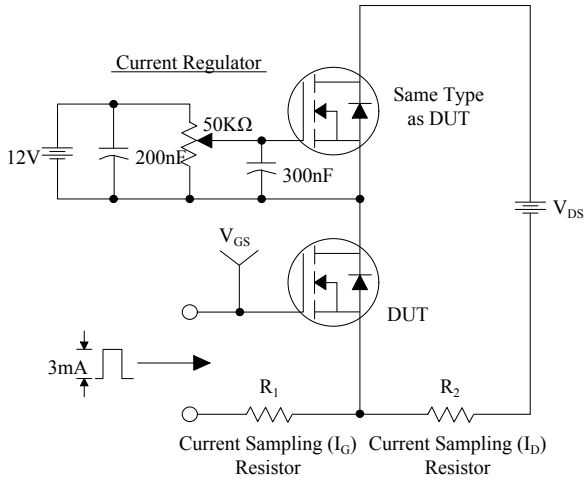
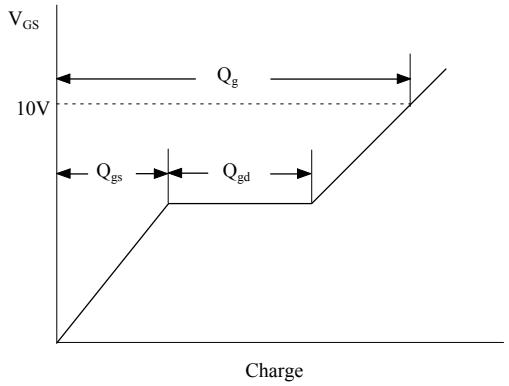


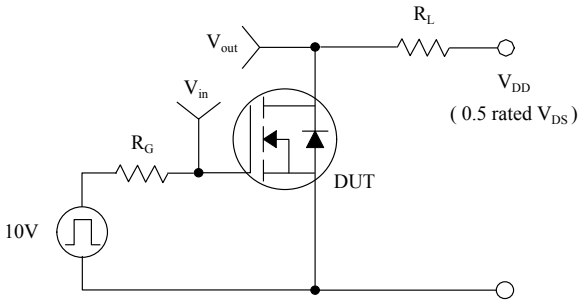
Figure 10. Maximum Drain Current vs Case Temperature

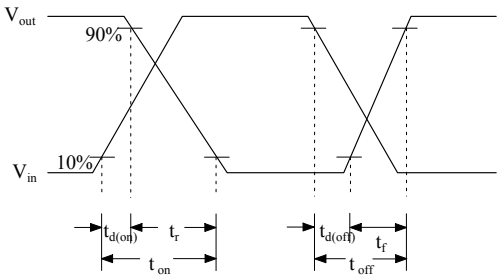
Gate Charge Test Circuit & Waveform



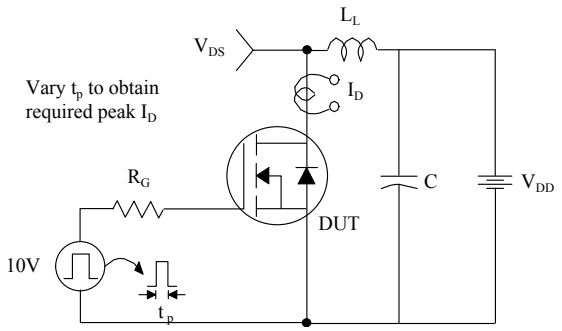


Resistive Switching Test Circuit & Waveforms

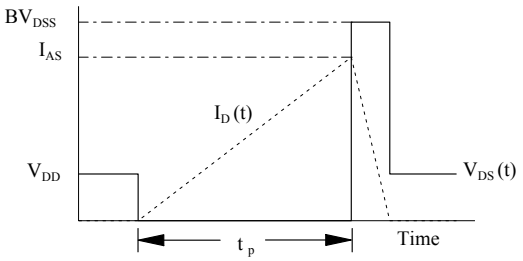




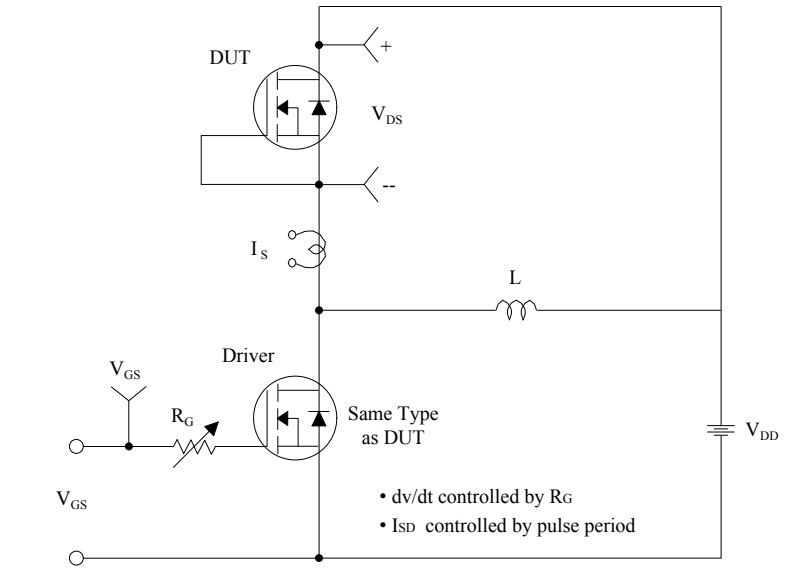
Unclamped Inductive Switching Test Circuit & Waveforms

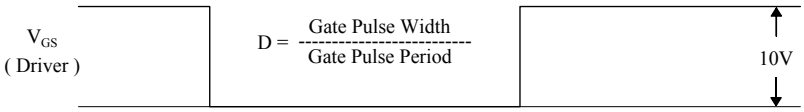


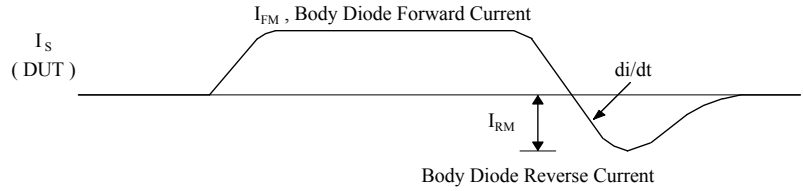
$$E_{AS} = \frac{1}{2} L_L I_{AS}^2 \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$

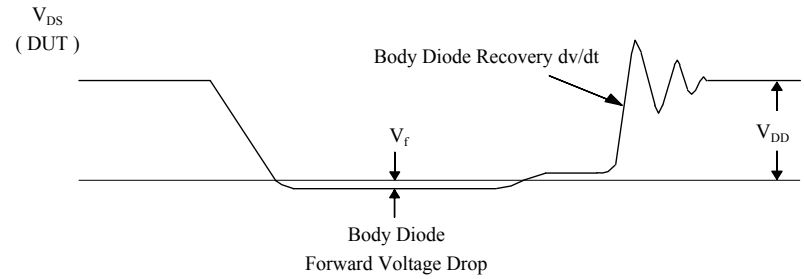


Peak Diode Recovery dv/dt Test Circuit & Waveforms









X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET ***category:***

Click to view products by Maplesemi ***manufacturer:***

Other Similar products are found below :

614233C 648584F MCH3443-TL-E MCH6422-TL-E FDPF9N50NZ FW216A-TL-2W FW231A-TL-E APT5010JVR NTNS3A92PZT5G IRF100S201 JANTX2N5237 2SK2464-TL-E 2SK3818-DL-E FCA20N60_F109 FDZ595PZ STD6600NT4G FSS804-TL-E 2SJ277-DL-E 2SK1691-DL-E 2SK2545(Q,T) D2294UK 405094E 423220D MCH6646-TL-E TPCC8103,L1Q(CM 367-8430-0972-503 VN1206L 424134F 026935X 051075F SBVS138LT1G 614234A 715780A NTNS3166NZT5G 751625C 873612G IRF7380TRHR IPS70R2K0CEAKMA1 RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3